Special Issue

Sensors and New Trends in Global Metrology

Message from the Guest Editors

The progressive digitization of science and enterprises is the main cause of the current changes in ensuring high-quality research and production. The purpose of the Special Issue is to create a platform for the exchange of views and experiences as well as the presentation of research results on new trends in the field of searching for and applying new sensor solutions and new trends in global metrology. The subject of the Special Issue concerns the most important development trends in sensors and modern legal and applied metrology. In particular, it includes electrical, medical, chemical, physical, industrial metrology, photometry, and radiometry.

Guest Editors

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Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

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